

Product Datasheet - Technical Specifications



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ME-5004 Opto-I/O Add-on Board for ME-5000 series

- Additional channel for ME-5000 cobalt series, saves PC resources:
16 inputs, 16 outputs, opto-isolated up to 1 kV; input range: 3...60 V variable, output range: 15...30 V variable.
- Source/sink/high-impedance: Sink 50 mA/channel, source 180...370 mA/channel. Source short circuit proof.
- Temperature monitoring cold->hot/hot->cold.
- Frequency output: 8 of the outputs, 3 kHz each.
- Frequency measurement: 8 of the inputs, 300 kHz.
- Bit change: All inputs interrupt capable + bit pattern comparator.
- Connectors: 37-pin D-sub female.
- Firmware configuration and variable channels.
- Uses one slot space, doesn't use the bus connector. Saves PC resources!
- For use with ME-5100, ME-5810A, ME-5810A/S.

Cannot be used with ME-5810B, ME-5810B/S, ME-5261, ME-5265, ME-5284.

Model	Opto in	Opto out	Opto counter	Standard firmware functions	Bus platform
ME-5004 PCIe	16	16	3	Single digital I/O, Frequency measurement (8 of the 16 inputs; 300 kHz each), frequency output (8 of the 16 outputs; 3 kHz each), bit pattern compare with interrupt, bit-change with interrupt	PCI-Express*
ME-5004 cPCI	16	16	3		3 HE CompactPCI/PXI*

* Included Add-on board, ME-Power-DVD with software and PDF user manual, 25-pin mating connector.

Specification

(Ambient temperature 25 °C)

PC Interface

PCI-Express-bus	32 bit, 33 MHz, 3.3 V, PCI-Express x 1 specification version 2.0
CompactPCI-bus	32 bit, 33 MHz, 5 V, PICMG 2.0 R3.0
Plug&Play	is fully supported

Digital Input/Output (general)

Measured Quantity	Condition/ Explanation	Value
Number inputs	subdevice 0 single mode operation	16 bit opto-isolated
Number of outputs	subdevice 1 (Single)	16 bit opto-isolated
Operation modes	Single	Software triggered read/write
	Interrupt	bit-pattern change, bit-pattern compare
Frequency input signal	symmetrical rectangular signal	max. 300 kHz
Frequency output signal	symmetrical rectangular signal	max. 3 kHz
External trigger inputs		DI_0..15, DO_0..15
External trigger edges		rising, falling, any
Input level	see the following tables	
Isolation voltage	U_{ISO} (f=60 Hz, t=60 s)	max. 1000 VAC _{rms}
Reference ground	opto-isolated inputs	GND_DI
	opto-isolated outputs	GND_DO

Opto-Isolated Inputs

Static values

Conditions: $T_A = 25^\circ\text{C}$

Measured Quantity	Test Criterion	MIN	Type	MAX	Unit
$U_{in,H}$		12	24	30	V
$U_{in,L}$		0		2.2	V
R_{in}	$U_{in}=24\text{ V}$		4.5		$\text{k}\Omega$
I_{in}	$U_{in}=24\text{ V}$		5.5		mA

Limiting Values

Measured Quantity	Condition/Explanation	Value
U_{RWM} over-voltage protection for inputs	max. 600 W pulse power at a pulse width of 1 ms	30 V

Opto-Isolated Outputs

Conditions: $T_A = 25^\circ\text{C}$

Output drivers	sink	2 x ULN2803			
	source	2 x ISO1H811G			
External supply	U_{ext}	15...30 V			
	U_{Lmax}	U_{ext}			

For further specifications see chapter sink driver resp. source driver.

Sink Driver (UDN2803)

Measured Quantity	Test Criterion	MIN	Type	MAX	Unit
$I_{out}=I_C$ (output current)	per channel			50	mA
	see also characteristics curves in diagram 15				
I_{CE} (output leakage current)	$U_{CE}=50\text{ V}, T_A=25^\circ\text{C}$ $U_{CE}=50\text{ V}, T_A=85^\circ\text{C}$			50 100	μA
$U_{CE(SAT)}$ (collector emitter saturation voltage)	$I_{out} = 350\text{ mA}$ $I_{out} = 200\text{ mA}$ $I_{out} = 100\text{ mA}$		1.3 1.1 0.9	1.6 1.3 1.1	V
I_R (clamp diode reverse current)	$U_R=50\text{ V}, T_A=25^\circ\text{C}$ $U_R=50\text{ V}, T_A=85^\circ\text{C}$			50 100	μA
U_F (clamp diode forward voltage)	$I_F=350\text{ mA}$			2.0	V
t_{on} (switch-on time)	$R_L=125\text{ }\Omega$, $U_{out}=50\text{ V}$ $C_L=15\text{ pF}$		0.1	1	μs

t_{off} (switch-off time)	$R_L = 125 \Omega$, $U_{\text{out}} = 50 \text{ V}$ $C_L = 15 \text{ pF}$		0.2	1	μs
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Output current

The maximum current per output (I_C) depends on the saturation voltage U_{CE} and is limited by the power dissipation of the sum of the channels to

$$P_{\text{tot}} = 1 \text{ W per chip:}$$

$$P_{\text{tot}} = P_0 + \dots + P_7 \leq 1 \text{ W (at } 70^\circ\text{C)}$$

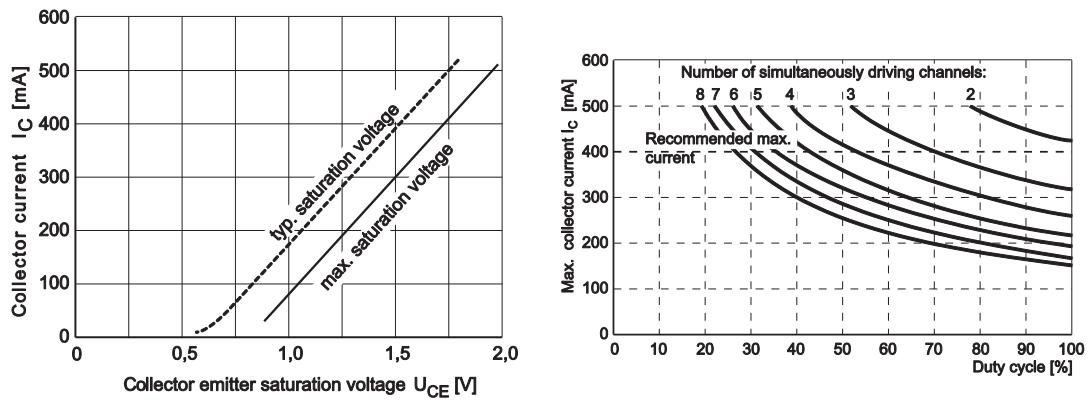


Diagram 15: Characteristic curves UDN2803

Source Driver (ISOH811G)

(short-circuit proof with current limiting and temperature monitoring)

Voltage Supply:

Conditions: $U_{\text{ext}} = 15 \dots 30 \text{ V}$, $T_J = -25 \dots +125^\circ\text{C}$

Measured Quantity	Test Criterion	MIN	Type	MAX	Unit
U_{out}	$U_{\text{ext}} = 24 \text{ V};$ 1 channel with $I_{\text{out}} = 0.625 \text{ A}$		23.8		V
	see Diagram 15				
I_{out} /channel	1 channel			625	mA
	16 channels			500	mA
U_{USD} (under-voltage shutdown)		7		10.5	V
R_{ON} (resistance if output active)	$I_{\text{out}} = 0.5 \text{ A}, T_J = 25^\circ\text{C}$		150 270	200 320	$\text{m}\Omega$ $\text{m}\Omega$

	$I_{out}=0.5 \text{ A}, T_J=125^\circ \text{ C}$				
I_S (current consumption driver ship)	8 channels active per chip; without load		10	14	mA
$I_{L(off)}$ (output in inactive state)	$U_{in} = U_{out} = 0 \text{ V}$	0	5	30	μA

Switching Times

Measured Quantity	Test Criterion	MIN	Type	MAX	Unit
t_{on} (switch-on time)	$R_L = 47 \Omega$, up to 90 % U_{out}		64	120	μs
t_{off} (switch-off time)	$R_L = 47 \Omega$, up to 10 % U_{out}		89	120	μs
$dU_{out}/dt_{(on)}$ (slope on switch-on)	$R_L = 47 \Omega$, at 0..30 % U_{out} $U_{ext} = 15 \text{ V}$		1	2	$\text{V}/\mu\text{s}$
$dU_{out}/dt_{(off)}$ (slope on switch-off)	$R_L = 47 \Omega$, at 70..40 % U_{out} $U_{ext} = 15 \text{ V}$		1	2	$\text{V}/\mu\text{s}$

Limiting Values

Measured Quantity	Test Criterion	MIN	Type	MAX	Unit
T_{CSD} (housing switch-off temperature)		125	130	135	$^\circ\text{C}$
T_{CR} (housing reset temperature)		110			$^\circ\text{C}$
T_{TSD} (junction switch-off temperature)		150	175	200	$^\circ\text{C}$
T_R (junction reset temperature)		135			$^\circ\text{C}$
I_{lim} (DC short-circuit current)	$U_{ext}=24 \text{ V}$, $R_L=10 \text{ m}\Omega$		1.1		A

Frequency Input/Output

Availability	alternative subdevice configuration via ME-iDC
Signal form	rectangular

Frequency Measuring Channels

Measured Quantity/ Criterion	Condition/Explanation	Value
Reference ground	isolated from PC ground	GND_DI
Number of channels	(FI_0...7)	8 inputs (opto-isolated)
Input I		see digital I/O
Input current		see digital I/O
Period (T)	$T_{\min.} = T_{\min.\text{asym.}} = T_{\min.\text{sym.}}$ $T_{\max.\text{asym}}$ $T_{\max.\text{sym}}$	3.3 µs (300 kHz) 16.25 s (0.06 Hz) 32.5 s (0.03 Hz)
Duty cycle	variable, depending on T	measurable in steps of 1 tick
Resolution	1 tick	15.15 ns
Accuracy		± 15.15 ns
Operating modes		„single“

Pulse Generator Channels

Measured Quantity/ Criterion	Condition/Explanation	Value
Reference ground	isolated from PC ground	GND_DO
Number of channels	(FO_0...7)	8 outputs (opto-isolated)
Output level	sink or source driver	see digital I/O
Period (T)	$T_{\min.} = T_{\min.\text{asym.}} = T_{\min.\text{sym.}}$ $T_{\max.\text{asym}}$ $T_{\max.\text{sym}}$	0.3 ms (3 kHz) 16,25 s (0,06 Hz) 32,5 s (0,03 Hz)
Duty cycle	variable, depending on T	to be set in steps of 1 tick
Resolution	1 tick	15.15 ns
Accuracy		± 15.15 ns
Operating modes		Single

Interrupt

Measured Quantity/ criterion	Condition/Explanation	Value
Interrupt sources	passed directly to the PC	bit-pattern change bit-pattern compare

General Data

Measured Quantity/ Criterion	Condition/Explanation	Value
Power supply	via base board	3.3 V/5 V
Current consumption	additional to base board	0.55...0.95 A (full load)
Fuses (see Diagram 3 page 14)	F2 (SMD-Fuse)	5 AT, Type: Littelfuse 419 SM
	F3 (SMD-Fuse)	5 AT, Type: Littelfuse 419 SM
Board dimensions (without slot bracket and connector)	base board requires its own slot	120 mm x 100 mm
Connections	ST1	37-pin D-sub female socket
Operating tempera- ture		0...70 °C
Storage temperature		-40...100 °C
Air humidity		20...55 % (non-condensing)
Certification	CE	

Pinout

Legend for pinouts:

Pin-name	Function
DI_0...15	digital inputs (subdevice 0)
DO_0...15	digital outputs (subdevice 1)
FI_0..7	frequency measurement inputs (alternative configuration)
FO_0...7	pulse generator outputs (alternative configuration)
VCC_EXT	VCC input for ext. power supply of isolated inputs and outputs, U_{ext} typ. 24 VDC
GND_DI	reference ground for isolated inputs (isolated from outputs and PC ground)
GND_DO	reference ground for isolated outputs (isolated from inputs and PC ground)

Note: In the configuration „pulse generator“ (FO) do not forget to take care of the unused pins DO_8..15. When used as sink drivers they are in high-impedance state, when used as source drivers they are connected to ground!

37-pin D-Sub (ST1)

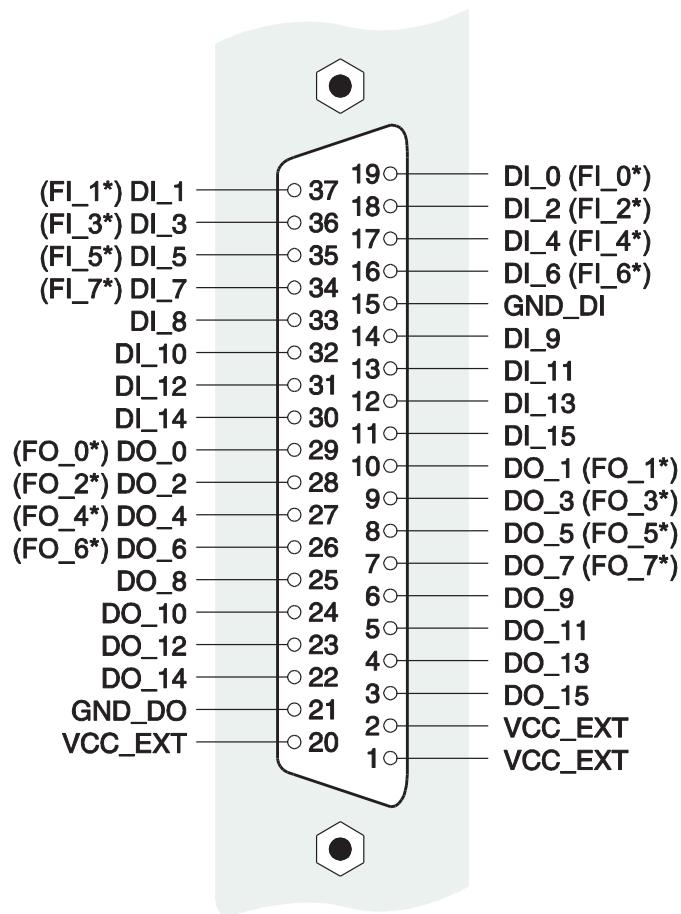


Diagram 16: 37-pin D-Sub female connector of the ME-5004 (ST1)

*These pins can only be used as frequency measurement inputs (FI_x) resp. pulse generator outputs (FO_x) after appropriate configuration of the corresponding subdevice with the ME-iDC. The remaining pins of the digital ports cannot be used for digital I/O.